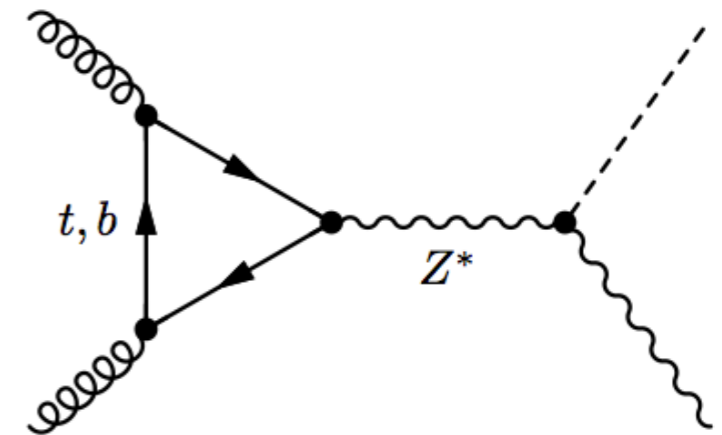
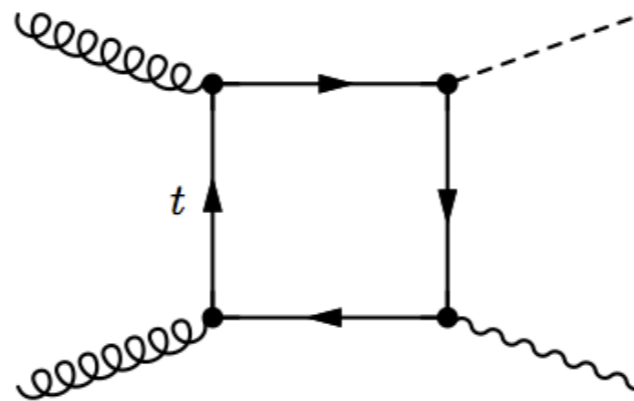
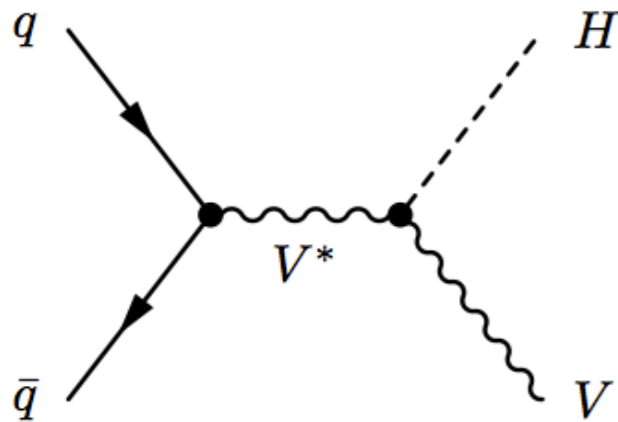


HXSWG1 - VH Towards STXS

Chris Palmer (Princeton University (US)),
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Carlo Enrico Pandini (CERN)
9 April 2018



Welcome Chris, joining Luca as CMS convener!



VH WG1 subgroup activities

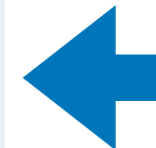
VH twiki: <https://twiki.cern.ch/twiki/bin/view/LHCPhysics/LHCHXSWGvH>

Mailing lists

- ▶ lhc-higgs-xsbr@cern.ch
[general WG1 thread - for discussions / meeting advertisement]
- ▶ lhc-higgs-vh-convener@cern.ch
[conveners mailing list for direct communication]
- ▶ lhc-higgs-xsbr-vhxbf@cern.ch is obsolete and **not used anymore!**

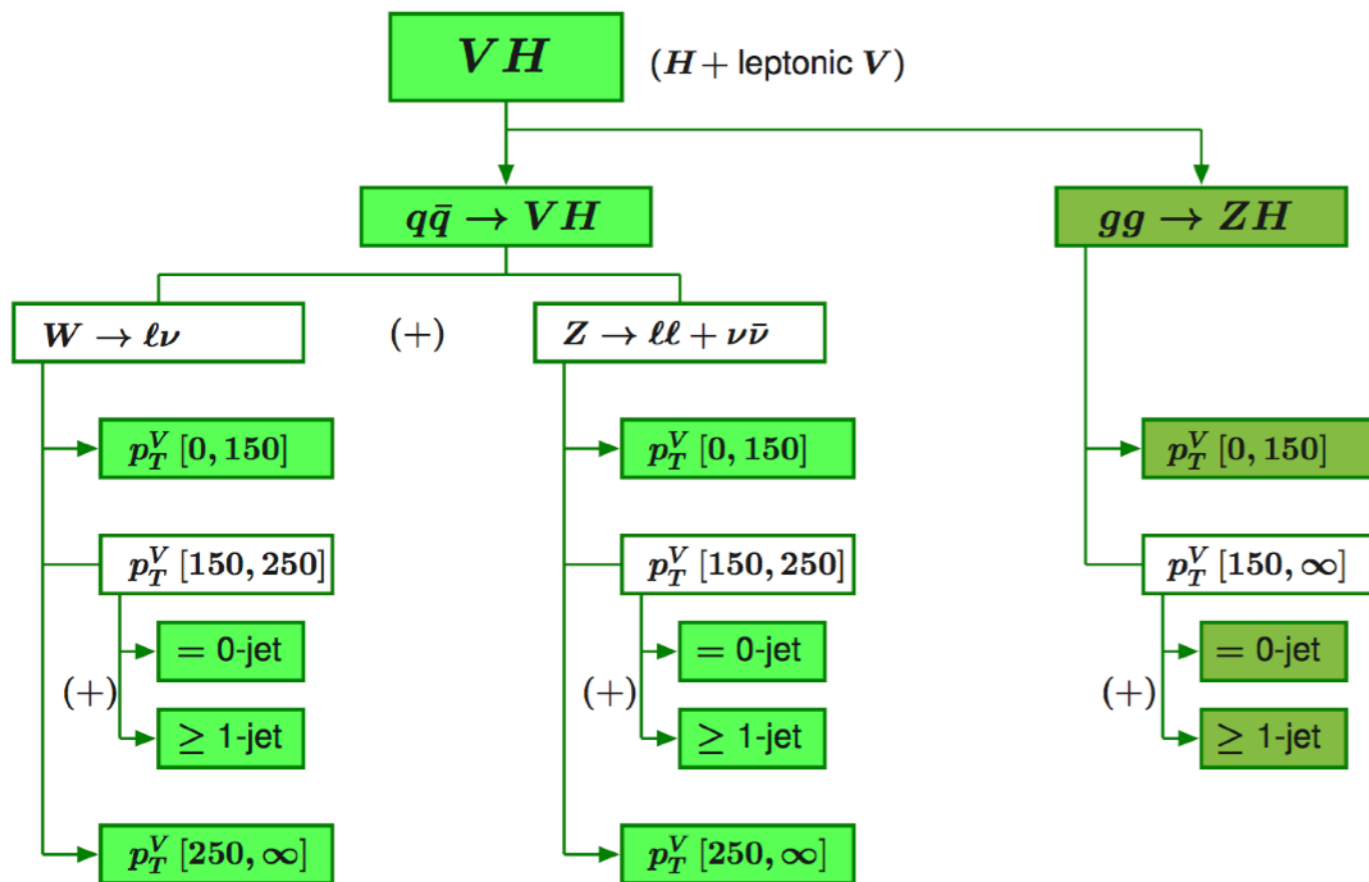
Indico page for VH WG1 meetings: <https://indico.cern.ch/category/5847/>

VH	VH XS prediction and uncertainties in STXS framework	Software tool providing central value and uncertainties + recommendations	~mid-summer 2018
VH	HL/HE-LHC 27TeV VH cross-section	VH cross-section and uncertainties calculation at 27TeV	few months / summer 2018
VH	V+hf modeling for VH(bb)	[public note] MC comparison across several V+hf MC tools targeting VH(bb) phase space, guidelines for theory uncertainties on V+hf predictions	autumn 2018
VH	ggZH merged predictions	[potentially public note] Comparison between showered ggZH 0+1jet merged LO MC prediction, and ggZH LO prediction	~mid-summer 2018



STXS for VH - short intro

- ▶ Stage-1 bin split mostly based on VH(bb) analysis categories / variables



- ▶ “VH” bins include leptonic VH (H undecayed)
- ▶ $qq \rightarrow V(qq)H$ as part of “VBF” bins
- ▶ $gg \rightarrow Z(qq)H$ as part of “ggF”
- ▶ Feedback on the bin split is still welcome, not set in stone!

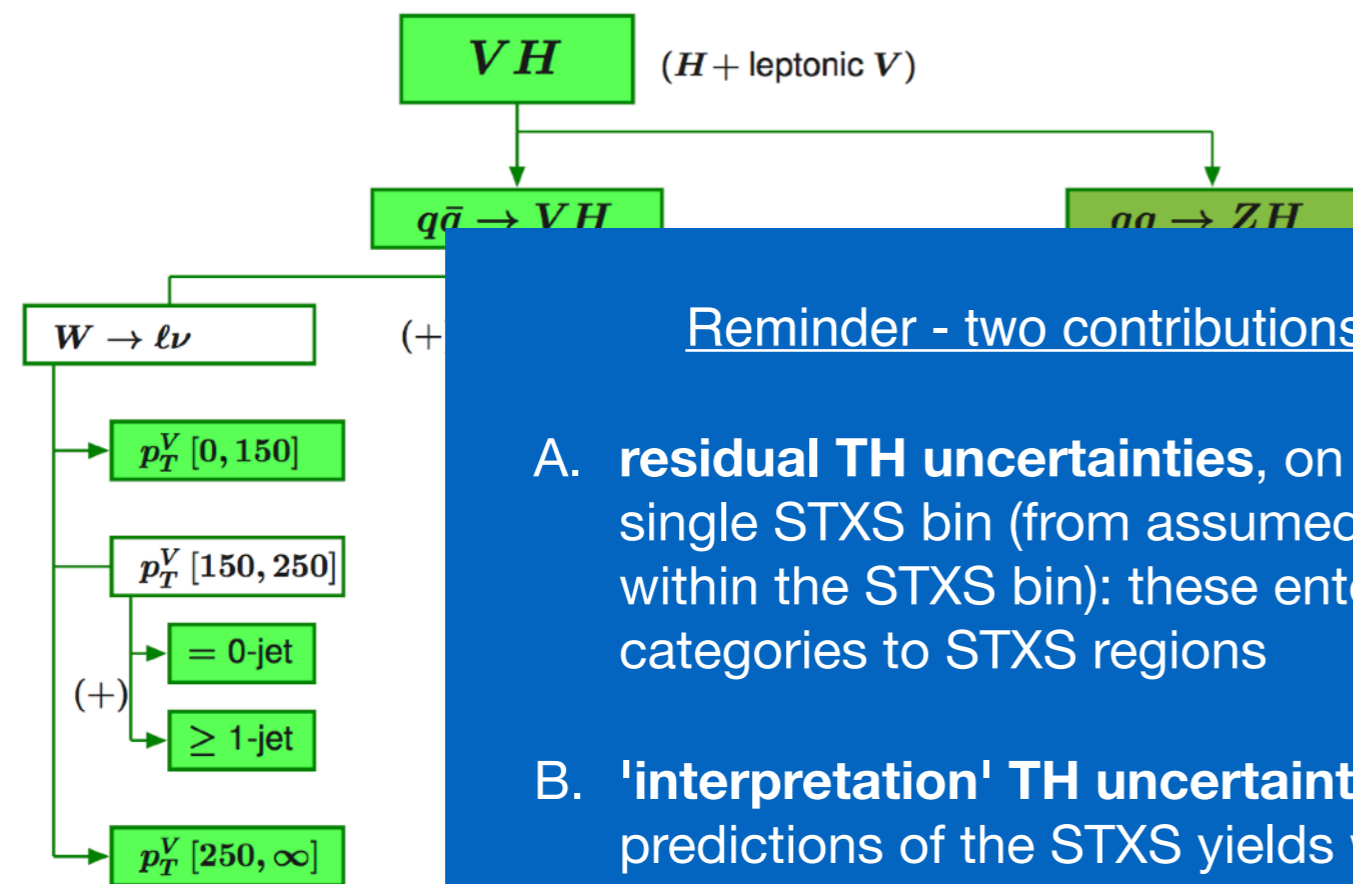
STXS \neq fiducial XS (and complementary)
 [fid/diff XS minimize theory dependence and acceptance corrections, decayed Higgs, ...]

- ▶ optimized for analysis sensitivity (e.g. in this case driven by VH(bb) categorization)
- ▶ reducing dominant theory dependence in the measurement (by moving it to the interpretation stage)
- ▶ reduced residual theory uncertainties within the measurement of each bin (if residual th. uncertainties become large in the exp. acceptance for a bin, the bin the be further split in sub-categories)

(reference from LesHouches2017)

STXS for VH - short intro

- ▶ Stage-1 bin split mostly based on VH(bb) analysis categories / variables



- ▶ “VH” bins include leptonic VH (H undecayed)
- ▶ $qq \rightarrow V(qq)H$ as part of “VBF” bins
- ▶ “ggF”

Reminder - two contributions from theory uncertainties

- residual TH uncertainties**, on the measurement of each single STXS bin (from assumed SM prediction of H kinematic within the STXS bin): these enter in the unfolding of exp. categories to STXS regions
- 'interpretation' TH uncertainties**, on the SM or BSM predictions of the STXS yields which enter in any subsequent interpretations

STXS scheme goal is to move the dominant TH unc. from A to B

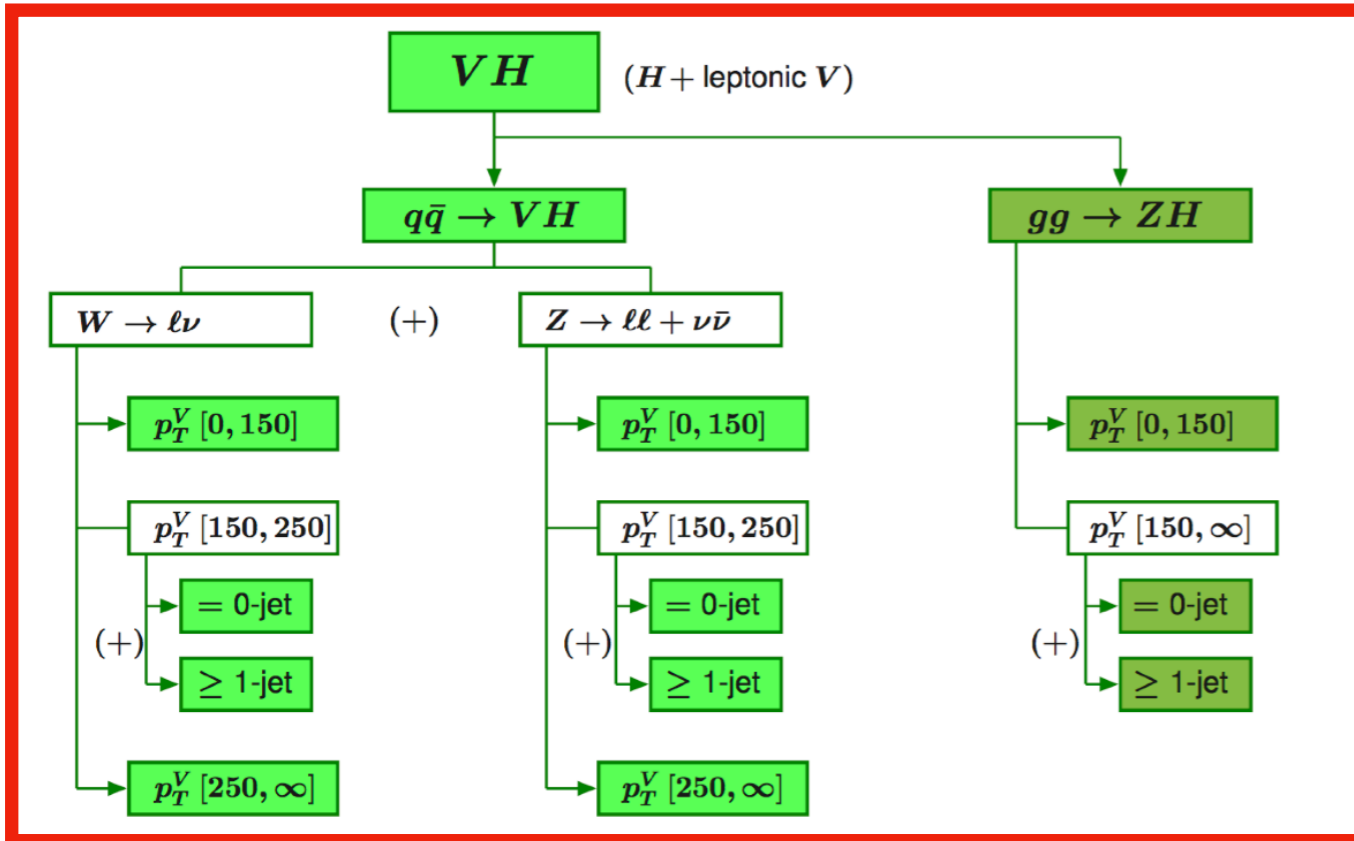
First step: addressing B

- ▶ optimized for
- ▶ reducing dom (by moving it
- ▶ reduced resid (if residual th. uncertainties become large in the exp. acceptance for a bin, the bin the be further split in sub-categories)

(reference from LesHouches2017)

STXS for VH - bin split

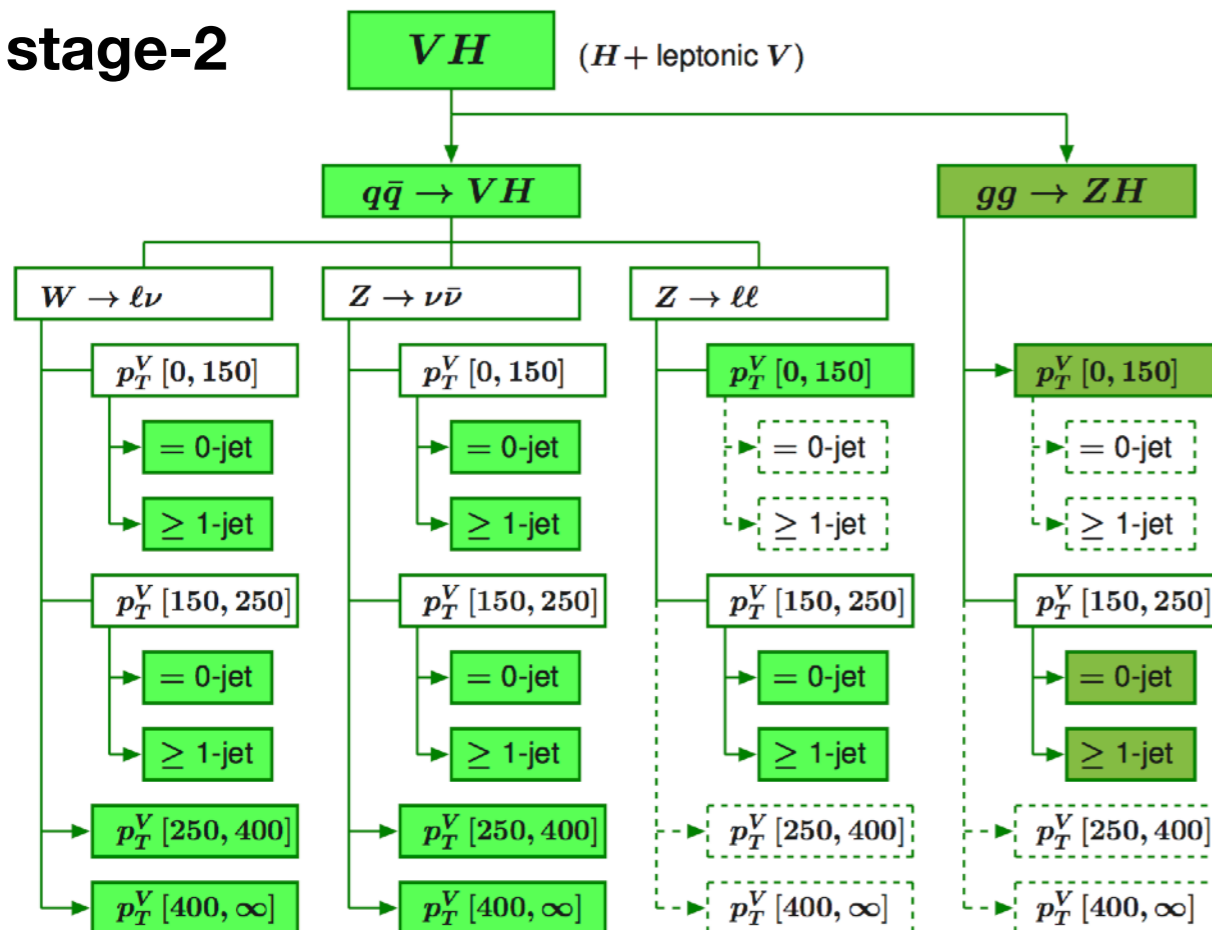
stage-1



Feedback on the bin split is still welcome, not set in stone!

- ▶ experimental analyses adopted a finer pTV split at below 150GeV: [75,150]+[150, ∞]
- ▶ split in exclusive jet-bins already in use across the whole pTV range, not only [150,250]GeV

stage-2



- ▶ jet-bin definition: exclusive or inclusive bins for higher jet multiplicities?
- ▶ high-pT (above 250GeV) intended as BSM-sensitive bins: could an mVH categorization be interesting?

(e.g. BSM effects in ggZH)

STXS for VH - uncertainty scheme

General parametrization of TH uncertainties for the **interpretation** step

Ideally: ATLAS & CMS publish the measured STXS in each bin \rightarrow TH prediction compared to the measurement with uncertainties coming directly from the table below

stage-1

	QCD uncertainties				EW uncertainties		
$q\bar{q}' \rightarrow W$	Δ_{WH}^y	Δ_{150}^{WH}	Δ_{250}^{WH}	$\Delta_{0/1}^{\text{WH}}$	$\Delta_{\text{Sud}}^{\text{WH}}$	$\Delta_{\text{hard}}^{\text{WH}}$	
$p_T^V [0,150]$	x_1	-1	$-y$		x_1	\dots	
$p_T^V [150,250]$	x_2	$+1 - y$	$-(1 - y)$	0	x_2	\dots	
= 0-jet	$x_2 z$	$+(1 - y)z$	$-(1 - y)z$	$+1$	\dots	\dots	
≥ 1 -jet	$x_2(1 - z)$	$+(1 - y)(1 - z)$	$-(1 - y)(1 - z)$	-1	\dots	\dots	
$p_T^V [250,\infty]$	x_3	y	$+1$		x_3	\dots	
$q\bar{q} \rightarrow Z$	Δ_{ZH}^y	Δ_{150}^{ZH}	Δ_{250}^{ZH}	$\Delta_{0/1}^{\text{ZH}}$	$\Delta_{\text{Sud}}^{\text{ZH}}$		$\Delta_{\text{hard}}^{\text{ZH}}$
$p_T^V [0,150]$	x_1	-1	$-y$		x_1		\dots
$p_T^V [150,250]$	x_2	$+1 - y$	$-(1 - y)$	0	x_2		\dots
= 0-jet	$x_2 z$	$+(1 - y)z$	$-(1 - y)z$	$+1$	\dots		\dots
≥ 1 -jet	$x_2(1 - z)$	$+(1 - y)(1 - z)$	$-(1 - y)(1 - z)$	-1	\dots		\dots
$p_T^V [250,\infty]$	x_3	y	$+1$		x_3		\dots

STXS for VH - uncertainty scheme

One word on the implementation of the uncertainty scheme:

Single bin-boundary a/b splitting the phase space in 2:

The a/b cut itself is a new source of uncertainty, which is not present on σ_{ab}
(e.g. jet-binning)

General parametrization of the uncertainty matrix = fully correlated + fully anti-correlated components

$$C(\{\sigma_a, \sigma_b\}) = \begin{pmatrix} (\Delta_a^y)^2 & \Delta_a^y \Delta_b^y \\ \Delta_a^y \Delta_b^y & (\Delta_b^y)^2 \end{pmatrix} + \begin{pmatrix} \Delta_{a/b}^2 & -\Delta_{a/b}^2 \\ -\Delta_{a/b}^2 & \Delta_{a/b}^2 \end{pmatrix}$$

► 2 independent nuisance parameter for each of the 3 observables $\{\sigma_{ab}, \sigma_a, \sigma_b\}$

*fully
correlated*

$$\theta^y : \{\Delta_{ab}^y, \Delta_a^y, \Delta_b^y\}$$

1st NP - overall yield uncertainty of a common source

*fully
anti-correlated*

$$\theta_{a/b} : \{0, \Delta_{a/b}, -\Delta_{a/b}\}$$

2nd NP - migration uncertainty introduced by the a/b cut
which **fully cancels out** in the a+b sum

This parametrization is useful also for theorists that want to identify and estimate each component of the uncertainty -- well known case of uncertainties in fixed-order or resummed calculation for jet-binning.

Note: example of single a/b boundary extendable to multiple regions / multiple boundaries

(reference in Section 6 from LH17)

STXS for VH - uncertainty scheme

Simple example: pTV split only
 $[0,150] + [150, 250] + [250, \infty]$

$$\begin{aligned} \sigma_{\text{tot}} &= \sigma_{[0,150]} + \\ &\quad \sigma_{[150,250]} + \\ &\quad \sigma_{[250,\infty]} \\ &= \sigma_{[0,150]} + \\ &\quad \sigma_{[150,\infty]} \end{aligned}$$

$$\sigma_{[150,\infty]} = \sigma_{[150,250]} + \sigma_{[250,\infty]}$$

$q\bar{q}' \rightarrow W$	Δ_{WH}^y	Δ_{150}^{WH}	Δ_{250}^{WH}
$p_T^V [0,150]$	x_1	-1	-y
$p_T^V [150,250]$	x_2	+1 - y	-(1 - y)
$p_T^V [250,\infty]$	x_3	y	+1

5 observables: $\{\sigma_{\text{tot}}, \sigma_{[0,150]}, \sigma_{[150,\infty]}, \sigma_{[150,250]}, \sigma_{[250,\infty]}\}$

$\theta^y : \{\Delta_{ab}^y, \Delta_a^y, \Delta_b^y\}$ **1NP $\rightarrow \theta^y$** : $\{\Delta_{\text{WH}}^y; \Delta_{[0,150]}^y; \Delta_{[150,\infty]}^y; \Delta_{[150,250]}^y; \Delta_{[250,\infty]}^y\}$

$$\Delta_{\text{WH}}^y = \Delta_{[0,150]}^y + \Delta_{[150,\infty]}^y$$

$$\Delta_{[150,\infty]}^y = \Delta_{[150,250]}^y + \Delta_{[250,\infty]}^y$$

x_i parameters in the table derived from the distribution of the overall yield uncertainty:

$$x_1 = \Delta_{[0,150]}^y / \Delta_{\text{WH}}^y$$

$$x_2 = \Delta_{[150,250]}^y / \Delta_{\text{WH}}^y$$

$$x_3 = \Delta_{[250,\infty]}^y / \Delta_{\text{WH}}^y$$

STXS for VH - uncertainty scheme

Simple example: pTV split only
 $[0,150] + [150, 250] + [250, \infty]$

$$\begin{aligned}\sigma_{\text{tot}} &= \sigma_{[0,150]} + \\ &\quad \sigma_{[150,250]} + \\ &\quad \sigma_{[250,\infty]} \\ &= \sigma_{[0,150]} + \\ &\quad \sigma_{[150,\infty]}\end{aligned}$$

$$\sigma_{[150,\infty]} = \sigma_{[150,250]} + \sigma_{[250,\infty]}$$

$q\bar{q}' \rightarrow W$	Δ_{WH}^y	Δ_{150}^{WH}	Δ_{250}^{WH}
$p_T^V [0,150]$	x_1	-1	-y
$p_T^V [150,250]$	x_2	+1 - y	-(1 - y)
$p_T^V [250,\infty]$	x_3	y	+1

5 observables: $\{\sigma_{\text{tot}}, \sigma_{[0,150]}, \sigma_{[150,\infty]}, \sigma_{[150,250]}, \sigma_{[250,\infty]}\}$

$$\theta_{a/b} : \{0, \Delta_{a/b}, -\Delta_{a/b}\} \quad \boxed{2\text{NP} \rightarrow \theta_{0/150} : \Delta_{150} \times \{0; 1; -1; -(1-y_1); -y_1\}}$$

$$\theta_{150/250} : \Delta_{250} \times \{0; y_2; -y_2; (1-y_2); -1\}$$

(A priori the y_i parameters don't have the same values)

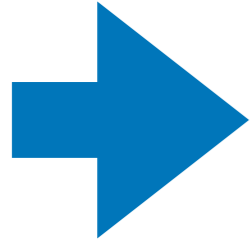
Uncertainties on the cross-section bins:

$$\begin{aligned}\text{unc.}(\sigma_{[0,150]}) &= x_1 \Delta_{\text{WH}}^y - \Delta_{150} - y_2 \Delta_{250} \\ \text{unc.}(\sigma_{[150,250]}) &= x_2 \Delta_{\text{WH}}^y + (1-y_1) \Delta_{150} - (1-y_2) \Delta_{250} \\ \text{unc.}(\sigma_{[250,\infty]}) &= x_3 \Delta_{\text{WH}}^y + y_1 \Delta_{150} + \Delta_{250}\end{aligned}$$

- ▶ Δ_{150} is the unc. induced by the cut at 150GeV, fully anticorrelated $\{+1;-1\}$ across the boundary, and distributed by y_1 over the $[150,\infty]$ region
- ▶ Δ_{250} is the unc. induced by the cut at 250GeV, fully anticorrelated $\{+1;-1\}$ across the boundary, and distributed by y_2 over the $[150,250]$ region

STXS for VH - uncertainty scheme

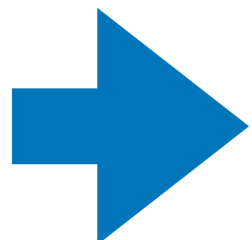
Ideally we want to provide a tool that implements this scheme with the state-of-the-art estimate of central values and uncertainties for/across each STXS bin.



the main item provided by this tool is the **parametrization scheme**
the tool itself has to be flexible enough to potentially accommodate a new/
different TH prediction with its own uncertainty estimate

First step - test the implementation with the available predictions

- ▶ start with MC samples used in experimental analyses: PowhegMiNLO [readily available]
- ▶ consider scale variations as first step - uncertainties from pTV and n-jet cuts
- ▶ start to build the uncertainty matrix from this first (simpler) example to spot potential issues and prepare the framework for more advanced TH predictions/estimates



deriving the $\{x, y, z\}$ and Δ parameters from slide 6

STXS for VH - uncertainty scheme

Example from Dag's talk for ggF -- full table of uncertainties for ggF categories

Cross sections and absolute uncertainties in pb											
STXS	sig	stat	mu	res	mig01	mig12	D60	D120	D200	Tot	
Incl	48.52 +/-	0.00	2.25	1.06	0.02	-0.01	-0.00	0.00	0.08	2.49	
FWDH	4.27 +/-	0.01	0.19	0.08	-0.02	-0.02	-0.02	-0.01	0.00	0.21	
VBF1	0.27 +/-	0.00	0.02	0.02	0.01	0.04	0.00	0.00	0.00	0.05	
VBF2	0.36 +/-	0.00	0.03	0.03	0.01	0.06	0.01	0.01	0.00	0.07	
0J	27.25 +/-	0.03	1.03	0.03	-1.12	0.00	0.00	0.00	0.00	1.52	
1J_0-60	6.49 +/-	0.01	0.35	0.30	0.52	-0.45	-0.79	-0.08	0.00	1.14	
1J_60	4.50 +/-	0.01	0.24	0.21	0.36	-0.31	0.52	-0.06	0.00	0.78	
1J_120	0.74 +/-	0.00	0.04	0.03	0.06	-0.05	0.09	0.08	0.00	0.15	
1J_200	0.15 +/-	0.00	0.01	0.01	0.01	-0.01	0.00	0.00	0.02	0.03	
2J_0-60	1.22 +/-	0.01	0.10	0.10	0.05	0.20	-0.15	-0.02	0.00	0.29	
2J_60	1.86 +/-	0.01	0.15	0.15	0.07	0.30	0.22	-0.02	0.00	0.43	
2J_120	0.99 +/-	0.00	0.08	0.08	0.04	0.16	0.11	0.10	0.00	0.25	
2J_200	0.42 +/-	0.00	0.03	0.03	0.02	0.07	0.00	0.00	0.06	0.10	
=0J	30.12 +/-	0.03	1.14	0.03	-1.24	0.00	0.00	0.00	0.00	1.68	
=1J	12.92 +/-	0.02	0.69	0.59	1.04	-0.90	-0.21	-0.07	0.02	1.66	
>=2J	5.47 +/-	0.01	0.43	0.43	0.22	0.88	0.21	0.07	0.06	1.12	
>=1J 60-200	9.09 +/-	0.01	0.57	0.53	0.59	0.17	1.05	0.11	0.00	1.45	
>=1J 120-200	1.96 +/-	0.01	0.13	0.13	0.11	0.14	0.23	0.21	0.00	0.40	
>=1J >200	0.58 +/-	0.00	0.04	0.04	0.03	0.06	0.00	0.00	0.08	0.12	
>=1J >60	9.68 +/-	0.01	0.61	0.57	0.62	0.22	1.05	0.11	0.08	1.51	
>=1J >120	2.54 +/-	0.01	0.18	0.17	0.14	0.20	0.23	0.21	0.08	0.47	
>=1	18.40 +/-	0.02	1.12	1.02	1.26	-0.01	-0.00	0.00	0.08	1.97	

STXS for VH - uncertainty scheme

Example from Dag's talk for ggF -- full table of uncertainties for ggF categories

Fractional impact of each uncertainty source										
STXS	sig	stat	mu	res	mig01	mig12	D60	D120	D200	
Total	abs uncertainty		2.25	1.04	1.25	0.88	1.05	0.21	0.08	
Incl	48.52 +/- 0.00		1.00	1.01	0.02	-0.01	-0.00	0.00	1.00	
FWDH	4.27 +/- 0.01		0.08	0.07	-0.02	-0.02	-0.02	-0.04	0.02	
VBF1	0.27 +/- 0.00		0.01	0.02	0.01	0.05	0.00	0.01	0.00	
VBF2	0.36 +/- 0.00		0.01	0.03	0.01	0.07	0.01	0.03	0.00	
0J	27.25 +/- 0.03		0.46	0.03	-0.90	0.00	0.00	0.00	0.00	
1J_0-60	6.49 +/- 0.01		0.15	0.29	0.42	-0.51	-0.74	-0.41	0.00	
1J_60	4.50 +/- 0.01		0.11	0.20	0.29	-0.35	0.49	-0.28	0.00	
1J_120	0.74 +/- 0.00		0.02	0.03	0.05	-0.06	0.08	0.38	0.00	
1J_200	0.15 +/- 0.00		0.00	0.01	0.01	-0.01	0.00	0.00	0.26	
2J_0-60	1.22 +/- 0.01		0.04	0.09	0.04	0.22	-0.14	-0.08	0.00	
2J_60	1.86 +/- 0.01		0.07	0.14	0.06	0.34	0.20	-0.12	0.00	
2J_120	0.99 +/- 0.00		0.03	0.07	0.03	0.18	0.11	0.50	0.00	
2J_200	0.42 +/- 0.00		0.01	0.03	0.01	0.08	0.00	0.00	0.72	
=0J	30.12 +/- 0.03		0.50	0.03	-0.99	0.00	0.00	0.00	0.00	
=1J	12.92 +/- 0.02		0.31	0.57	0.83	-1.02	-0.20	-0.36	0.26	
>=2J	5.47 +/- 0.01		0.19	0.41	0.17	1.00	0.20	0.36	0.74	
>=1J 60-200	9.09 +/- 0.01		0.25	0.51	0.47	0.19	1.00	0.55	0.00	
>=1J 120-200	1.96 +/- 0.01		0.06	0.12	0.09	0.16	0.22	1.00	0.00	
>=1J >200	0.58 +/- 0.00		0.02	0.04	0.02	0.07	0.00	0.00	1.00	
>=1J >60	9.68 +/- 0.01		0.27	0.55	0.50	0.26	1.00	0.55	1.00	
>=1J >120	2.54 +/- 0.01		0.08	0.16	0.11	0.22	0.22	1.00	1.00	
>=1	18.40 +/- 0.02		0.50	0.98	1.01	-0.01	-0.00	0.00	1.00	

Sum across the column gives back 1, and the absolute uncertainty on the single category is obtained from each single x-value:

$$0J - 2.25 * 0.46 = 1.03$$

STXS for VH - uncertainty sources and estimates

Second step - uncertainty estimate

For the QCD uncertainties, we identify the following sources/nuisance parameters:

- $\theta_{\text{VH}}^y, \theta_{gg \rightarrow ZH}^y$: The overall yield uncertainty for the underlying VH production process.
- $\theta_{150}^{\text{VH}}, \theta_{150}^{gg \rightarrow ZH}$: The migration uncertainty related to the $p_T^V = 150$ GeV bin boundary.
- θ_{250}^{VH} : The migration uncertainty related to the $p_T^V = 250$ GeV bin boundary.
- $\theta_{0/1}^{\text{VH}}, \theta_{0/1}^{gg \rightarrow ZH}$: The migration uncertainty related to the 0/1-jet bin boundary.

fixed-order predictions?

sensitive to resummation effects:
resummed calculations or
parton-shower MCs

Uncertainty from the modeling of parton-shower effects not included right now, but usually one of the dominant in the Higgs signal model

For the EW uncertainties, we identify the following sources/nuisance parameters:

- $\theta_{\text{Sud}}^{\text{VH}}$: The uncertainty related to EW Sudakov effects.
- $\theta_{\text{hard}}^{\text{WH}}, \theta_{\text{hard}}^{\text{ZH}}$: The uncertainty related to hard EW (non-Sudakov) effects.

How do we want to estimate
EW uncertainties?

The theoretical uncertainties of integrated cross sections originating from unknown higher-order EW effects can be estimated by

$$\Delta_{\text{EW}} = \max\{0.5\%, \delta_{\text{EW}}^2, \Delta_\gamma\}. \quad (\text{I.5.18})$$

This estimate is based on the maximum of the generic size $\sim 0.5\%$ of the neglected NNLO EW effects, taking into account a possible systematic enhancement $\sim \delta_{\text{EW}}^2$, and the potentially large relative uncertainty $\Delta_\gamma = \Delta\sigma_\gamma/\sigma$ of the photon-induced contribution σ_γ , whose absolute uncertainty $\Delta\sigma_\gamma$ can be read from the tables.

STXS for VH - uncertainty sources and estimates

Second step - uncertainty estimate

For the QCD uncertainties, we identify the following sources/nuisance parameters:

- $\theta_{\text{VH}}^y, \theta_{gg \rightarrow ZH}^y$: The overall yield uncertainty for the underlying VH production process.
- $\theta_{150}^{\text{VH}}, \theta_{150}^{gg \rightarrow ZH}$: The migration uncertainty related to the $p_T^V = 150$ GeV bin boundary.
- θ_{250}^{VH} : The migration uncertainty related to the $p_T^V = 250$ GeV bin boundary.
- $\theta_{0/1}^{\text{VH}}, \theta_{0/1}^{gg \rightarrow ZH}$: The migration uncertainty related to the 0/1-jet bin boundary.

fixed-order predictions?

sensitive to resummation effects:

relations or
MCs

Uncertainty from
now, but use

Correlation of uncertainties with other Higgs production modes
not discussed here and now, but we'll need to address it

E.g.

EW-uncertainty VH-VBF correlation
QCD-uncertainty ggZH-ggH correlation
?

For the EW uncertainty

- $\theta_{\text{Sud}}^{\text{VH}}$: The uncertainty from Sudakov effects.
- $\theta_{\text{hard}}^{\text{WH}}, \theta_{\text{hard}}^{\text{ZH}}$: The uncertainty from hard EW corrections.

ant to estimate
uncertainties?

The theoretical uncertainties of integrated cross sections originating from unknown higher-order EW effects can be estimated by

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This estimate is based on the maximum of the generic size $\sim 0.5\%$ of the neglected NNLO EW effects, taking into account a possible systematic enhancement $\sim \delta_{\text{EW}}^2$, and the potentially large relative uncertainty $\Delta_\gamma = \Delta\sigma_\gamma/\sigma$ of the photon-induced contribution σ_γ , whose absolute uncertainty $\Delta\sigma_\gamma$ can be read from the tables.

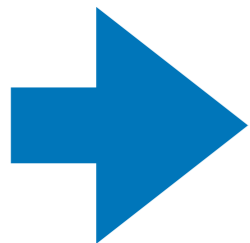
STXS for VH - on the experimental side ...

Implementation of the uncertainty scheme first intended to provide a parametrization for the interpretation of STXS results

Not 'meant' to address residual TH uncertainties within the STXS bins

however

When bins are merged in a measurement (e.g. not enough sensitivity), we are re-introducing the dependence on the $XS(\text{bin1})/XS(\text{bin2})$ SM prediction with its uncertainty



Consistent treatment of uncertainty on the measurement and the interpretation sides is important

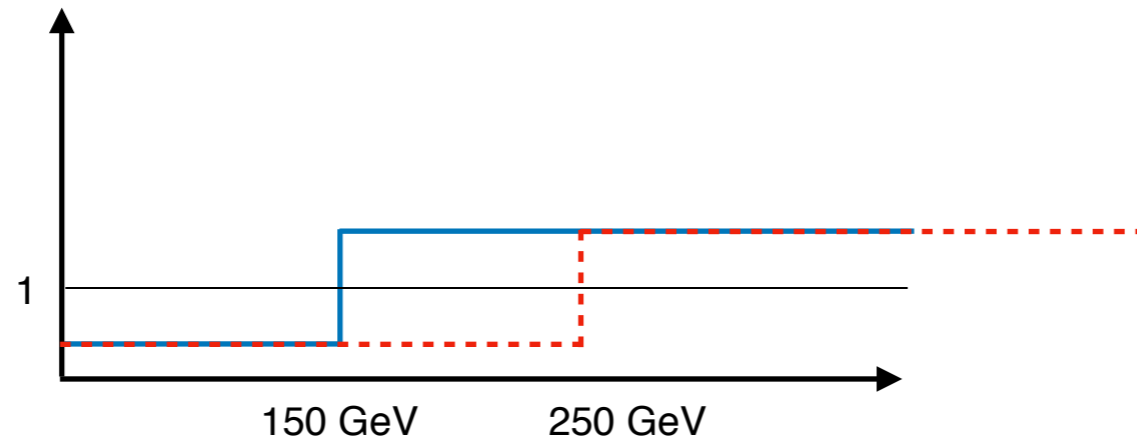
Uncertainty on variables whose shape information is critical in the experimental analyses should be encoded as a continuous shape variation, to facilitate a consistent treatment within the measured bins and across the boundaries

pTV shape is the critical candidate for VH

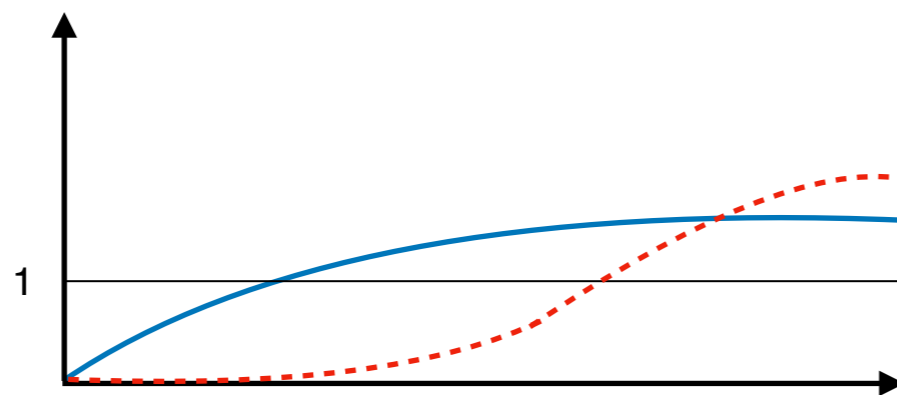
(shape information control the bin-bin migration and enters in the MVA discriminant)

STXS for VH - on the experimental side ... shapes

- ▶ $\theta_{0/150}$ and $\theta_{150/250}$ act effectively like 2 'shape-variations' with inflection point at 150 and 250 GeV and no residual shape in the bins



- ▶ $\theta_{0/150}$ and $\theta_{150/250}$ are uncorrelated: these **two** parameters are not intended to encode the shape variations from QCD scale variations across the pTV range (which is probably not clearly defined), but rather the uncertainty induced by the **two** cuts on pTV
- ▶ What do we usually intend with 'pTV shape variation' in the experimental analyses?

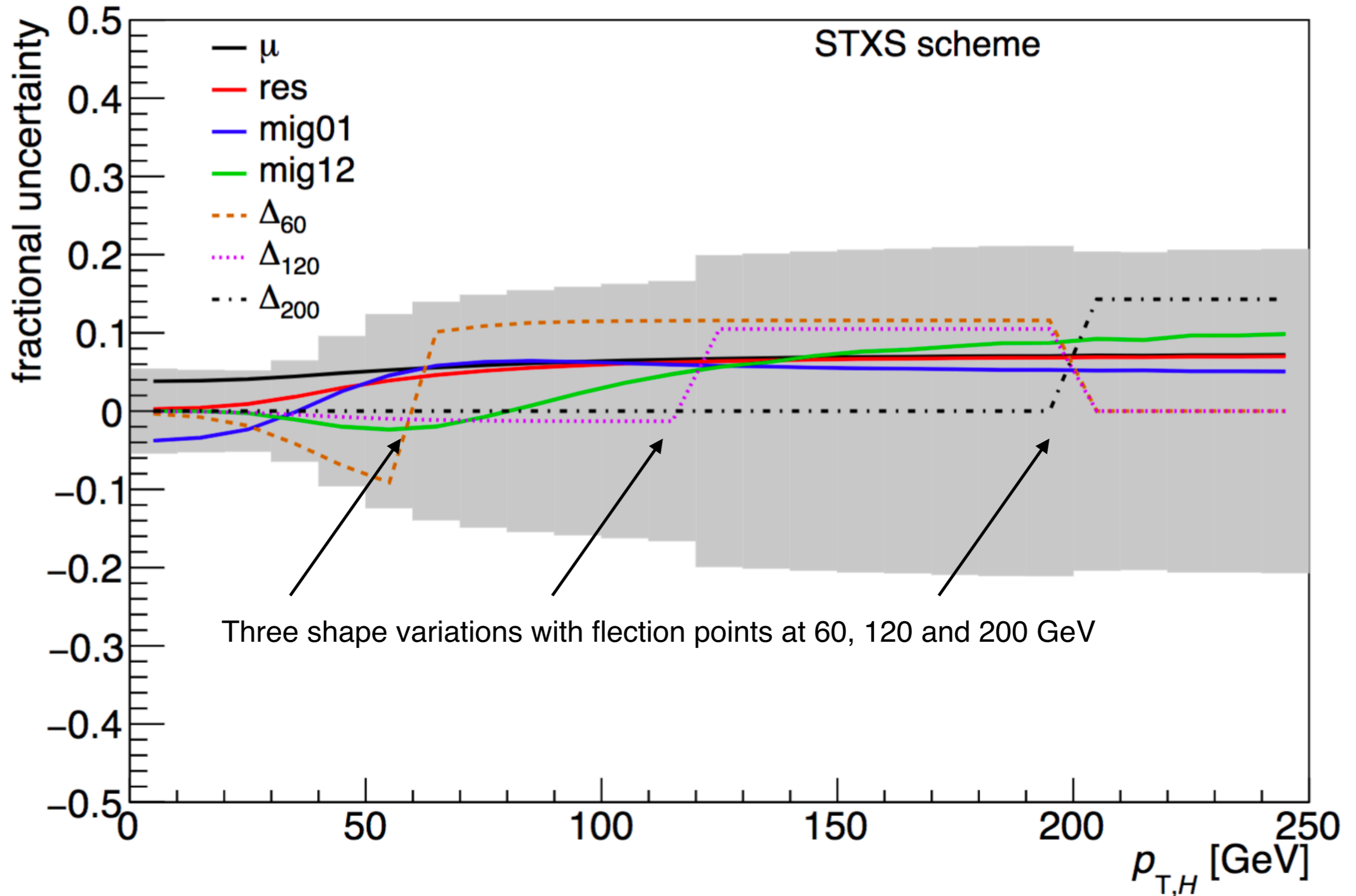


Each of the θ parameter would correspond to a separate shape systematic with different inflection points

- ▶ one example of this kind of implementation comes directly from ggH:

STXS for VH - on the experimental side ...

Shape uncertainties: example from ggH

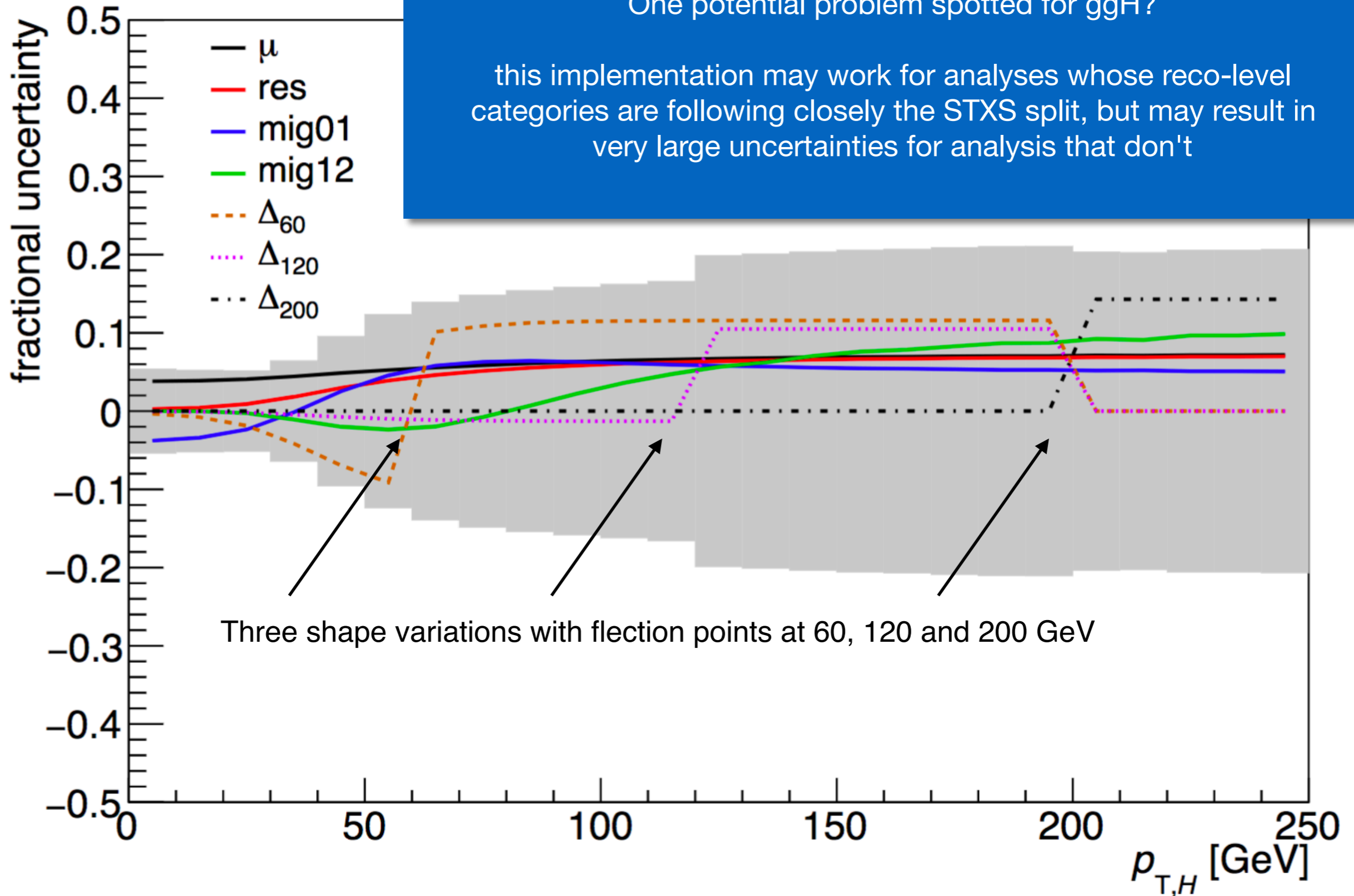


STXS for VH - on the experimental side ...

Shape uncertainties: example from qqH

One potential problem spotted for ggH?

this implementation may work for analyses whose reco-level categories are following closely the STXS split, but may result in very large uncertainties for analysis that don't



Conclusions and operative steps

- ▶ First step towards STXS: start by available MC samples with QCD scale variations included and work to derive a first 'draft' of the uncertainty table

this is a first quick step, but can already reveal possible issues to address [help/manpower from exp. groups? potentially not trivial to make plots/numbers public with a quick turnaround, but we should work around this]

- ▶ start discussing which tools we want to use for the estimate of all uncertainties:
 - ▶ fixed order prediction consistent with YR4? (vh@nnlo)
 - ▶ resummed calculation / parton-shower MC?
 - ▶ EW uncertainties: how to divide between Sudakow and non-Sudakow effects, how to estimate the uncertainty?
(can the new POWHEG-BOX-V2 implementation with NLO EW included be helpful?)
 - ▶ parton-shower effects ???
- ▶ implementation of uncertainties on variables whose shape information is used in the analyses has to be treated with care -- discussion

BACK-UP

STXS for VH - uncertainty scheme

Example from Dag's talk for ggF -- full table of uncertainties for ggF categories

- Using ATLAS MC (Powheg NNLOPS) normalized to N₃LO @m_H = 125.09 GeV

Cross sections and fractional uncertainties												
STXS	sig	stat	mu	res	mig01	mig12	pTH	qm_b	qm_top	Tot		
Incl	48.52 +/-	0.00	+4.6%	+2.2%	+0.0%	-0.0%	-0.1%	-0.2%	+0.0%	+5.1%		
FWDH	4.27 +/-	0.01	+4.4%	+1.8%	-0.5%	-0.4%	-0.5%	-0.6%	-1.5%	+5.1%		
VBF1	0.27 +/-	0.00	+7.9%	+7.9%	+3.9%	+16.2%	-2.5%	-2.4%	+0.1%	+20.3%		
VBF2	0.36 +/-	0.00	+7.9%	+7.9%	+3.9%	+16.2%	-0.9%	-1.1%	+0.2%	+20.1%		
0J	27.25 +/-	0.03	+3.8%	+0.1%	-4.1%	+0.0%	+0.0%	-0.2%	+0.0%	+5.6%		
1J_0-60	6.49 +/-	0.01	+5.3%	+4.6%	+8.1%	-6.9%	-4.5%	-4.0%	+0.0%	+14.1%		
1J_60	4.50 +/-	0.01	+5.3%	+4.6%	+8.1%	-6.9%	+3.0%	+4.9%	+0.0%	+14.0%		
1J_120	0.74 +/-	0.00	+5.3%	+4.6%	+8.1%	-6.9%	+14.0%	+5.0%	+0.5%	+19.6%		
1J_200	0.15 +/-	0.00	+5.3%	+4.6%	+8.1%	-6.9%	+16.0%	+5.0%	+10.5%	+23.5%		
2J_0-60	1.22 +/-	0.01	+7.9%	+7.9%	+3.9%	+16.2%	-7.4%	-7.2%	+0.0%	+22.5%		
2J_60	1.86 +/-	0.01	+7.9%	+7.9%	+3.9%	+16.2%	-1.0%	-0.1%	+0.0%	+20.0%		
2J_120	0.99 +/-	0.00	+7.9%	+7.9%	+3.9%	+16.2%	+6.8%	+5.0%	+0.6%	+21.7%		
2J_200	0.42 +/-	0.00	+7.9%	+7.9%	+3.9%	+16.2%	+15.5%	+5.0%	+11.8%	+28.3%		
=0J	30.12 +/-	0.03	+3.8%	+0.1%	-4.1%	+0.0%	+0.0%	-0.2%	-0.2%	+5.6%		
=1J	12.92 +/-	0.02	+5.3%	+4.6%	+8.1%	-6.9%	-0.3%	+0.0%	+0.2%	+12.7%		
>=2J	5.47 +/-	0.01	+7.9%	+7.9%	+3.9%	+16.1%	+0.1%	-0.7%	+1.1%	+20.0%		
>=1J 60-200	9.09 +/-	0.01	+6.3%	+5.8%	+6.5%	+1.8%	+3.4%	+3.7%	+0.2%	+12.0%		
>=1J 120-200	1.96 +/-	0.01	+6.9%	+6.6%	+5.6%	+7.0%	+9.6%	+5.0%	+0.6%	+17.0%		
>=1J >200	0.58 +/-	0.00	+7.2%	+7.0%	+5.0%	+10.1%	+15.6%	+5.0%	+11.4%	+25.0%		
>=1J >60	9.68 +/-	0.01	+6.3%	+5.9%	+6.4%	+2.3%	+4.2%	+3.8%	+0.8%	+12.4%		
>=1J >120	2.54 +/-	0.01	+6.9%	+6.7%	+5.4%	+7.7%	+11.0%	+5.0%	+3.1%	+18.4%		
>=1	18.40 +/-	0.02	+6.1%	+5.6%	+6.8%	-0.1%	-0.2%	-0.2%	+0.5%	+10.7%		

The 11 ggF STXS bins

Multiple bin boundaries: example.

- 3 mutually exclusive jet bins: $\{\sigma_0, \sigma_1, \sigma_{\geq 2}\}$
- Identify 2 boundaries: $\sigma_{\geq 0} = \sigma_0 + \sigma_{\geq 1}$ and $\sigma_{\geq 1} = \sigma_1 + \sigma_{\geq 2}$
- Nuisance parameters for five observables $\{\sigma_{\geq 0}, \sigma_0, \sigma_{\geq 1}, \sigma_1, \sigma_{\geq 2}\}$

$$\kappa^y : \{\Delta_{\geq 0}^y, \Delta_0^y, \Delta_{\geq 1}^y, \Delta_1^y, \Delta_{\geq 2}^y\} \text{ with}$$

$$\Delta_{\geq 0}^y = \Delta_0^y + \Delta_{\geq 1}^y, \quad \Delta_{\geq 1}^y = \Delta_1^y + \Delta_{\geq 2}^y$$

$$\kappa_{\text{cut}}^{0/1} : \Delta_{\text{cut}}^{0/1} \times \{0, 1, -1, -(1 - x_1), -x_1\}$$

$$\kappa_{\text{cut}}^{1/2} : \Delta_{\text{cut}}^{1/2} \times \{0, x_2, -x_2, 1 - x_2, -1\}$$

- ★ x_1 determines how $\Delta_{\text{cut}}^{0/1}$ is split between σ_1 and $\sigma_{\geq 2}$
- ★ x_2 determines how $\Delta_{\text{cut}}^{1/2}$ is split between σ_0 and σ_1
- Independent of particular theory framework, and maintains interpretation in terms of underlying physical sources
 - ★ Allows to judge correlations between different observables
 - ★ Associate each source with one nuisance parameter

Notes

$$\sigma_{\geq 0} = \sigma_0(p_T^{\text{cut}}) + \sigma_{\geq 1}(p_T^{\text{cut}})$$

from here

$$C(\{\sigma_0, \sigma_{\geq 1}\}) = \begin{pmatrix} (\Delta_0^y)^2 & \Delta_0^y \Delta_{\geq 1}^y \\ \Delta_0^y \Delta_{\geq 1}^y & (\Delta_{\geq 1}^y)^2 \end{pmatrix} + \begin{pmatrix} \Delta_{\text{cut}}^2 & -\Delta_{\text{cut}}^2 \\ -\Delta_{\text{cut}}^2 & \Delta_{\text{cut}}^2 \end{pmatrix}$$

$$\kappa^y : \quad \{\Delta_{\geq 0}^y, \Delta_0^y, \Delta_{\geq 1}^y\}$$

$$\kappa_{\text{cut}} : \quad \{0, \Delta_{\text{cut}}, -\Delta_{\text{cut}}\},$$

FO-ST

$$\Delta_0^y = \Delta_{\geq 0}^y = \Delta_{\geq 0}^{\text{FO}}, \quad \Delta_{\geq 1}^y = 0, \quad \Delta_{\text{cut}} = \Delta_{\geq 1}^{\text{FO}}$$

- Migration uncertainty is approximated by perturbative uncertainty of $\sigma_{\geq 1}(p_T^{\text{cut}})$, motivated by structure of perturbative series
- Perturbative uncertainties in $\sigma_{\geq 0}$ and $\sigma_{\geq 1}$ treated as independent sources

Notes

$$X_{\text{Stot}} = X_{\text{S}(0,150)} + X_{\text{S}(150,250)} + X_{\text{S}(250,\text{inf})}$$

{ X_{Stot} ; $X_{\text{S}(0,150)}$; $X_{\text{S}(150,\text{inf})}$; $X_{\text{S}(150,250)}$; $X_{\text{S}(250,\text{inf})}$ } --> 5 observables

Example:

$$f(0,150) = X_{\text{S}(0,150)} / X_{\text{Stot}} = 0.8$$

$$f(150,250) = X_{\text{S}(150,250)} / X_{\text{Stot}} = 0.13$$

$$f(250,\text{inf}) = X_{\text{S}(250,\text{inf})} / X_{\text{Stot}} = 0.07$$

$$X_{\text{Stot}} = 1.0$$

Percentage uncertainty bin-by-bin (relative to the bin itself)

$$\Delta Y(0,150) [\%] = 5\% \quad (5\% \text{ of } 0.8 \text{ --> } 0.04)$$

$$\Delta Y(150,250) [\%] = 10\% \quad (10\% \text{ of } 0.13 \text{ --> } 0.013)$$

$$\Delta Y(250,\text{inf}) [\%] = 15\% \quad (15\% \text{ of } 0.07 \text{ --> } 0.0105)$$

$$\Delta Y_{\text{tot}} [\%] = 6.35\% \quad (6.35\% \text{ of } 1.0 \text{ --> } 0.0635)$$

$$\Delta Y(150,\text{inf}) [\%] = 11.75\% \quad (11.75\% \text{ of } 0.2 \text{ --> } 0.0235)$$

VH Signal Model @ 13TeV

$m_H = 125 \text{ GeV at } \sqrt{s} = 13\text{TeV}$				
Process	Cross section \times BR [fb]	Acceptance [%]		
		0-lepton	1-lepton	2-lepton
$q\bar{q} \rightarrow (Z \rightarrow \ell\ell)(H \rightarrow b\bar{b})$	29.9	< 0.1	< 0.1	7.0
$gg \rightarrow (Z \rightarrow \ell\ell)(H \rightarrow b\bar{b})$	4.8	< 0.1	< 0.1	15.7
$q\bar{q} \rightarrow (W \rightarrow \ell\nu)(H \rightarrow b\bar{b})$	269.0	0.2	1.0	–
$q\bar{q} \rightarrow (Z \rightarrow \nu\nu)(H \rightarrow b\bar{b})$	89.1	1.9	–	–
$gg \rightarrow (Z \rightarrow \nu\nu)(H \rightarrow b\bar{b})$	14.3	3.5	–	–

Table 8: Summary of the systematic uncertainties in the signal modelling. “PS/UE” indicates parton shower / underlying event. An “S” symbol is used when only a shape uncertainty is assessed.

Signal	
Cross-section (scale)	0.7% (qq), 27% (gg)
Cross-section (PDF)	1.9% ($qq \rightarrow WH$), 1.6% ($qq \rightarrow ZH$), 5% (gg)
Branching ratio	1.7 %
Acceptance from scale variations (var.)	2.5% – 8.8% (Stewart-Tackmann jet binning method)
Acceptance from PS/UE var. for 2 or more jets	10.0% – 13.9% (depending on lepton channel)
Acceptance from PS/UE var. for 3 jets	12.9%–13.4% (depending on lepton channel)
Acceptance from PDF+ α_s var.	0.5%–1.3%
m_{bb}, p_T^V , from scale var.	S
m_{bb}, p_T^V , from PS/UE var.	S
m_{bb}, p_T^V , from PDF+ α_s var.	S
p_T^V from NLO EW correction	S

Talking points with VH(bb) CMS analysis

CMS		Individual contribution to the μ uncertainty (%)	Effect of removal to the μ uncertainty (%)
Source	Type		
1 Scale factors ($t\bar{t}$, V+jets)	norm.	9.4	3.5
2 Size of simulated samples	shape	8.1	3.1
3 Simulated samples' modeling	shape	4.1	2.9
b tagging efficiency	shape	7.9	1.8
Jet energy scale	shape	4.2	1.8
5 Signal cross sections	norm.	5.3	1.1
Cross section uncertainties (single-top, VV)	norm.	4.7	1.1
4 Jet energy resolution	shape	5.6	0.9
b tagging mistag rate	shape	4.6	0.9
Integrated luminosity	norm.	2.2	0.9
Unclustered energy	shape	1.3	0.2
Lepton efficiency and trigger	norm.	1.9	0.1

CMS $1.19^{+0.21}_{-0.20}(\text{stat})^{+0.34}_{-0.32}(\text{syst})$

ATLAS $1.20^{+0.24}_{-0.23}(\text{stat})^{+0.34}_{-0.28}(\text{syst})$

ATLAS

Source of uncertainty	σ_μ
Total	0.39
Statistical	0.24
Systematic	0.31
Experimental uncertainties	
Jets	0.03
E_T^{miss}	0.03
Leptons	0.01
4 b-tagging	
b-jets	0.09
c-jets	0.04
light jets	0.04
extrapolation	0.01
Pile-up	0.01
Luminosity	0.04
Theoretical and modelling uncertainties	
1 Signal	0.17
Floating normalisations	0.07
Z + jets	0.07
3 W + jets	0.07
$t\bar{t}$	0.07
Single top quark	0.08
Diboson	0.02
Multijet	0.02
2 MC statistical	0.13

Signal-uncertainties: as part of the effort on STXS, can we harmonise their treatment? (interesting towards combination)

Smoking gun: parton-shower uncertainties

Backgrounds: as part of the V+hf modeling studies, better definition of systematic handles from theoretical modeling of these processes

(Participation from the VH(bb) experts is critical here)

CMS Stage-0 STXS

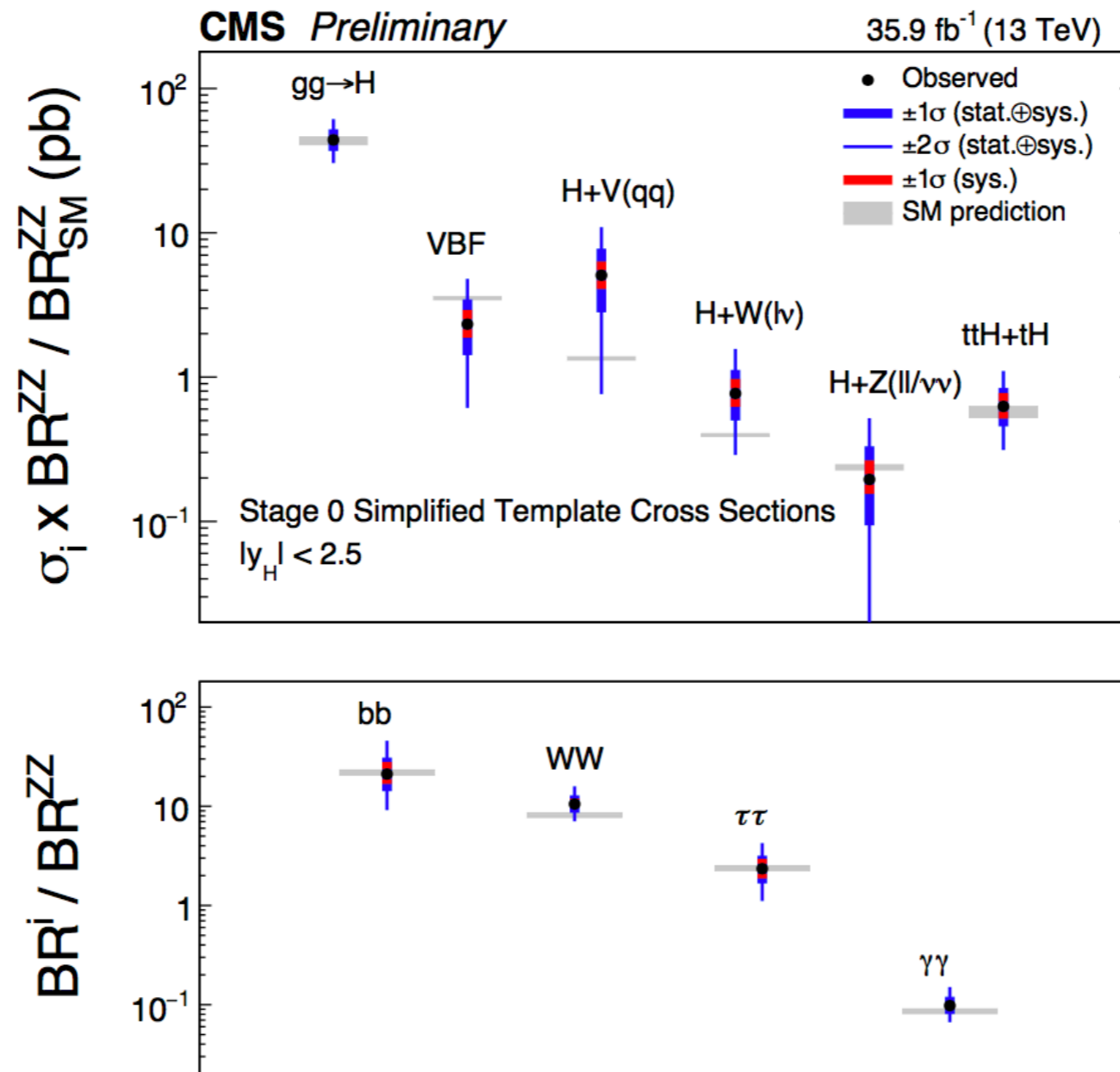


Figure 8: Summary of the stage 0 model, ratios of cross sections and branching ratios. The points indicate the best-fit values while the error bars show the $\pm 1\sigma$ and $\pm 2\sigma$ uncertainties. Also shown are the $\pm 1\sigma$ uncertainties on the measurements considering only the contributions from the systematic uncertainties. Also shown are the uncertainties on the SM predictions.

Simplified Template Cross Sections - VH

STXS: separating measurements from interpretations

- ▶ maximize measurements sensitivity
- ▶ minimize theory dependence (models&systematics)
- ▶ combine **all decay channels**
- ▶ measure **XS instead of signal strengths**
- ▶ measure XS separately for **production modes**
- ▶ measure XS in **simplified fiducial volumes**
- ▶ allow for advanced analysis techniques (**MVAs**)

Exclusive phase space regions (“bins”) defined to

- ▶ maximize experimental sensitivity
- ▶ minimize dependence on theory uncertainties directly folded into the measurements
- ▶ provide sensitivity to BSM scenarios

$$\sigma^{\text{meas}} = A^{\text{ggH}} \times \mu_{\text{ggH}} \times \sigma_{\text{ggH}}^{\text{SM}} + A^{\text{VBF}} \times \mu_{\text{VBF}} \times \sigma_{\text{VBF}}^{\text{SM}}$$

$$\downarrow$$

$$= A^{\text{ggH}} \times \sigma_{\text{ggH}} + A^{\text{VBF}} \times \sigma_{\text{VBF}}$$

A^{ggH} Signal acceptance
 A^{VBF} theory dependent

$$\sigma^{\text{meas}} = A_a^{\text{ggH}} \times \sigma_a^{\text{ggH}}^{\text{SM}} + A_b^{\text{ggH}} \times \sigma_b^{\text{ggH}}^{\text{SM}} + A_c^{\text{VBF}} \times \sigma_c^{\text{VBF}}^{\text{SM}} \quad \text{a,b,c = “bins” of STXS}$$

A_i^{ggH} Signal acceptance dependent on SM signal kinematic only within the given bin “i”

A_i^{VBF} [reduce theory dependence]

$gg \rightarrow ZH$ (loop-induced) MC modeling

